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Team Nexperia



PBSS302ND 40 V, 4 A NPN Iow V_{CEsat} (BISS) transistor Rev. 02 — 18 February 2008

Product data sheet

1. Product profile

1.1 General description

NPN low V_{CEsat} Breakthrough In Small Signal (BISS) transistor in a SOT457 (SC-74) small Surface-Mounted Device (SMD) plastic package.

PNP complement: PBSS302PD.

1.2 Features

- Ultra low collector-emitter saturation voltage V_{CEsat}
- 4 A continuous collector current capability I_C
- Up to 15 A peak current
- Very low collector-emitter saturation resistance
- High efficiency due to less heat generation

1.3 Applications

- Power management functions
- Charging circuits
- DC-to-DC conversion
- MOSFET gate driving
- Power switches (e.g. motors, fans)
- Thin Film Transistor (TFT) backlight inverter

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{CEO}	collector-emitter voltage	open base	-	-	40	V
I _C	collector current		<u>[1]</u> _	-	4	А
I _{CM}	peak collector current	single pulse; $t_p \leq 1 \text{ ms}$	-	-	15	A
R _{CEsat}	collector-emitter saturation resistance	I _C = 6 A; I _B = 600 mA	<u>[2]</u> _	55	75	mΩ

[1] Device mounted on a ceramic Printed-Circuit Board (PCB), Al₂O₃, standard footprint.

[2] Pulse test: $t_p \le 300 \ \mu s$; $\delta \le 0.02$.



40 V, 4 A NPN low V_{CEsat} (BISS) transistor

Pinning information 2.

Table 2.	Pinning				
Pin	Description	Simplified outline	Symbol		
1	collector				
2	collector		1, 2, 5, 6		
3	base	9	3		
4	emitter		4		
5	collector		4 sym014		
6	collector				

Ordering information 3.

Table 3. Order	ing informa	ation		
Type number	Package			
	Name	Description	Version	
PBSS302ND	SC-74	plastic surface-mounted package (TSOP6); 6 leads	SOT457	

Marking 4.

Table 4.	Marking codes	
Type num	ber	Marking code
PBSS302	ID	C7

Limiting values 5.

Table 5. **Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{CBO}	collector-base voltage	open emitter	-	60	V
V _{CEO}	collector-emitter voltage	open base	-	40	V
V _{EBO}	emitter-base voltage	open collector	-	5	V
I _C	collector current		<u>[1]</u> _	4	А
I _{CM}	peak collector current	single pulse; $t_p \le 1 \text{ ms}$	-	15	А
I _B	base current		-	0.8	А
I _{BM}	peak base current	single pulse; $t_p \leq 1 ms$	-	2	А
P _{tot}	total power dissipation	$T_{amb} \le 25 \ ^{\circ}C$	[2] _	360	mW
			[3] _	600	mW
			[4] _	750	mW
			<u>[1]</u> -	1.1	W
			[2][5]	2.5	W

40 V, 4 A NPN low V_{CEsat} (BISS) transistor

Table 5.	Limiting	values	continued
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In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
Tj	junction temperature		-	150	°C
T _{amb}	ambient temperature		-65	+150	°C
T _{stg}	storage temperature		-65	+150	°C

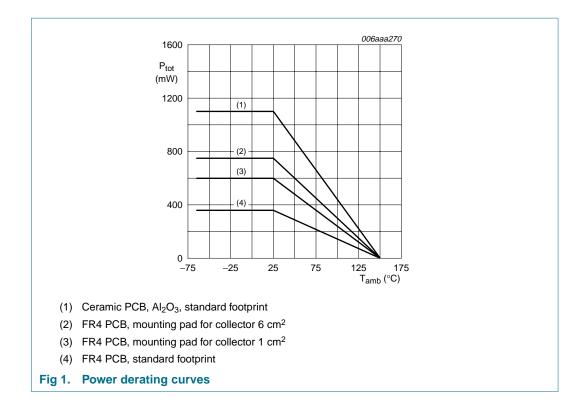
[1] Device mounted on a ceramic PCB, Al₂O₃, standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[3] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm².

[4] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm².

[5] Operated under pulsed conditions: Duty cycle $\delta \le 10$ % and pulse width $t_p \le 10$ ms.



40 V, 4 A NPN low V_{CEsat} (BISS) transistor

6. Thermal characteristics

Table 6.	Thermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-a)} thermal resistance from junction to ambient	thermal resistance from	in free air	<u>[1]</u> _	-	350	K/W
		[2] _	-	208	K/W	
			[3] _	-	167	K/W
			<u>[4]</u> _	-	113	K/W
			[1][5]	-	50	K/W
R _{th(j-sp)}	thermal resistance from junction to solder point		-	-	45	K/W

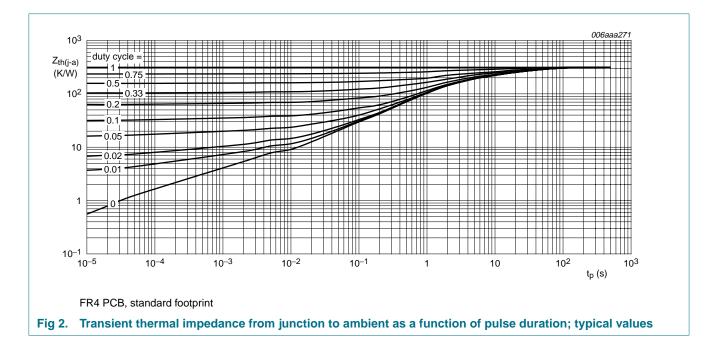
[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm².

[3] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm².

[4] Device mounted on a ceramic PCB, Al₂O₃, standard footprint.

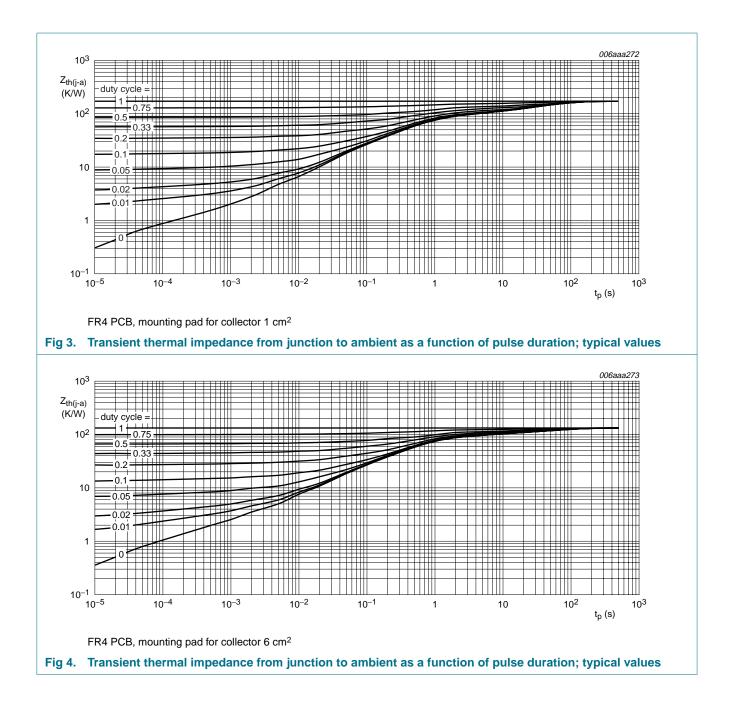
[5] Operated under pulsed conditions: Duty cycle δ \leq 10 % and pulse width t_{p} \leq 10 ms.



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PBSS302ND

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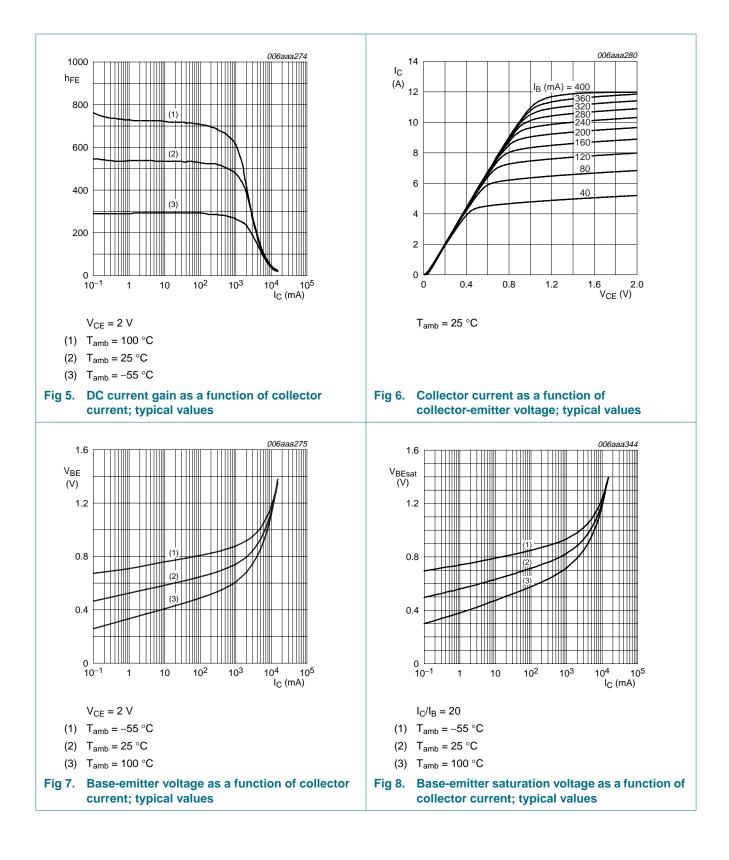
7. Characteristics

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
I _{CBO}	collector-base cut-off	$V_{CB} = 40 \text{ V}; I_E = 0 \text{ A}$		-	-	0.1	μA
	current	$\label{eq:VCB} \begin{array}{l} V_{CB} = 40 \; V; \; I_E = 0 \; A; \\ T_j = 150 \; ^\circ C \end{array}$		-	-	50	μΑ
I _{CES}	collector-emitter cut-off current	$V_{CE} = 30 \text{ V}; V_{BE} = 0 \text{ V}$		-	-	0.1	μΑ
I _{EBO}	emitter-base cut-off current	$V_{EB} = 5 V; I_{C} = 0 A$		-	-	0.1	μΑ
h _{FE} DC current gain		V_{CE} = 2 V; I_{C} = 0.5 A		300	500	-	
		$V_{CE} = 2 \text{ V}; \text{ I}_{C} = 1 \text{ A}$	[1]	300	475	-	
		$V_{CE} = 2 V; I_C = 2 A$	[1]	250	385	-	
		$V_{CE} = 2 V; I_C = 4 A$	[1]	100	190	-	
		$V_{CE} = 2 V; I_C = 6 A$	[1]	50	100	-	
V _{CEsat}	collector-emitter	$I_{C} = 0.5 \text{ A}; I_{B} = 50 \text{ mA}$		-	35	60	mV
saturation voltage	saturation voltage	I _C = 1 A; I _B = 50 mA		-	65	110	mV
		I _C = 2 A; I _B = 200 mA		-	115	180	mV
		I _C = 4 A; I _B = 400 mA	[1]	-	220	300	mV
		$I_{\rm C} = 6 \text{ A}; I_{\rm B} = 600 \text{ mA}$	[1]	-	330	450	mV
R _{CEsat}	collector-emitter saturation resistance	$I_{C} = 6 \text{ A}; I_{B} = 600 \text{ mA}$	<u>[1]</u>	-	55	75	mΩ
V _{BEsat}	base-emitter	$I_{C} = 0.5 \text{ A}; I_{B} = 50 \text{ mA}$		-	0.79	0.85	V
	saturation voltage	I _C = 1 A; I _B = 50 mA		-	0.81	0.9	V
		I _C = 1 A; I _B = 100 mA	[1]	-	0.83	1	V
		I _C = 4 A; I _B = 400 mA	[1]	-	1.0	1.1	V
V _{BEon}	base-emitter turn-on voltage	$V_{CE} = 2 V; I_{C} = 2 A$		-	0.79	1.0	V
t _d	delay time	$V_{CC} = 10 \text{ V}; I_{C} = 2 \text{ A};$		-	12	-	ns
t _r	rise time	$I_{Bon} = 0.1 A;$		-	52	-	ns
t _{on}	turn-on time	$I_{Boff} = -0.1 \text{ A}$		-	64	-	ns
t _s	storage time			-	390	-	ns
t _f	fall time			-	120	-	ns
t _{off}	turn-off time			-	510	-	ns
f⊤	transition frequency	$V_{CE} = 10 \text{ V}; I_{C} = 0.1 \text{ A};$ f = 100 MHz		-	150	-	MHz
C _c	collector capacitance	$V_{CB} = 10 \text{ V}; I_E = i_e = 0 \text{ A};$ f = 1 MHz		-	30	-	pF

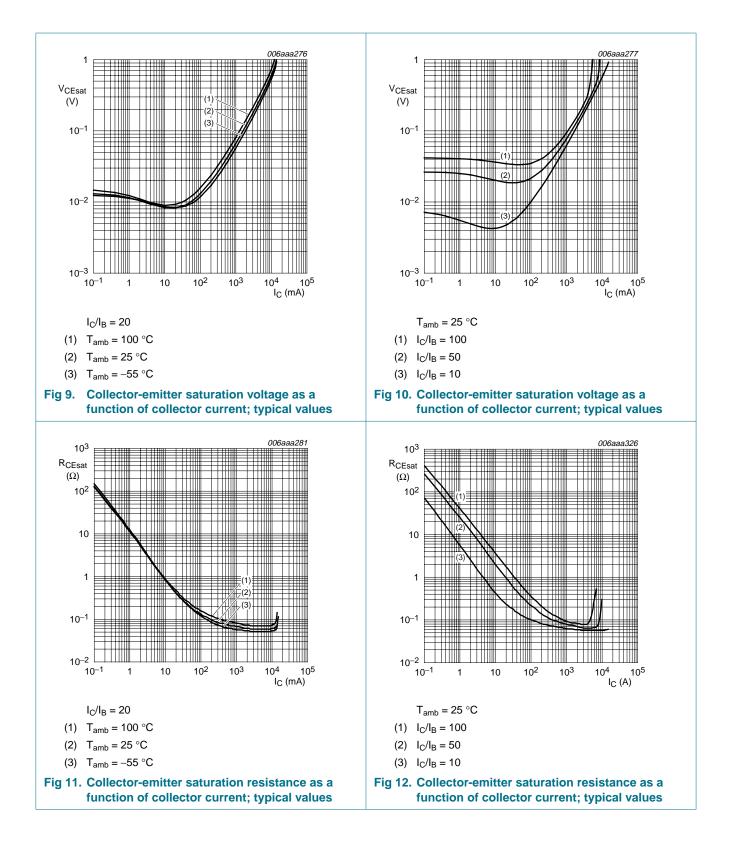
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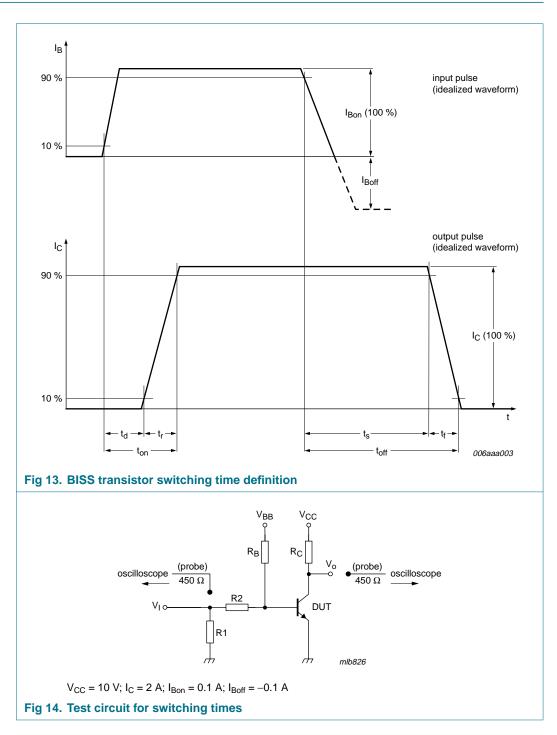


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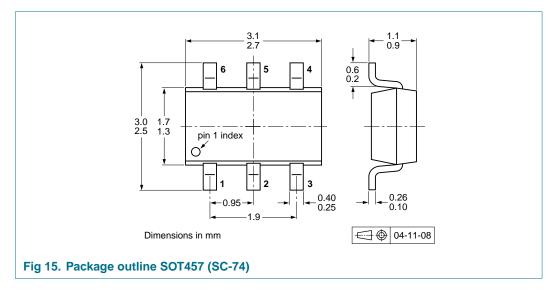
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8. Test information



40 V, 4 A NPN low V_{CEsat} (BISS) transistor

9. Package outline



10. Packing information

Table 8. Packing methods

The indicated -xxx are the last three digits of the 12NC ordering code.[1]

Type number Package De		Description		Packing quantity	
				3000	10000
PBSS302ND Se	SOT457	4 mm pitch, 8 mm tape and reel; T1	[2]	-115	-135
		4 mm pitch, 8 mm tape and reel; T2	[3]	-125	-165

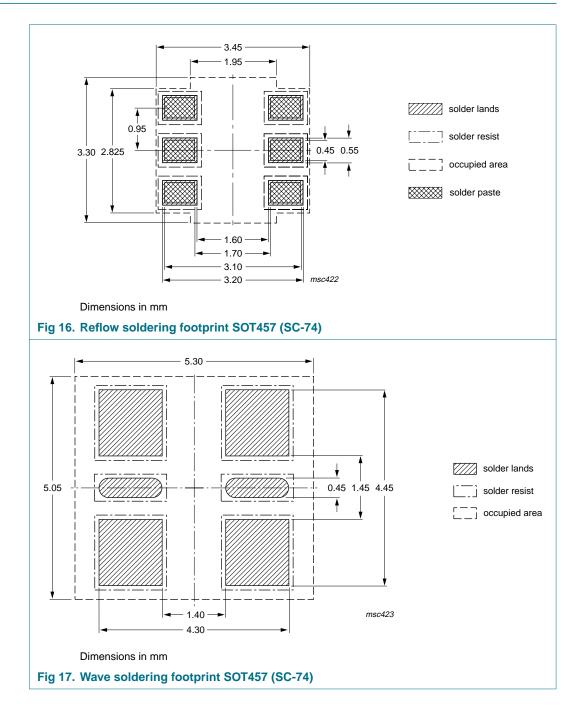
[1] For further information and the availability of packing methods, see <u>Section 14</u>.

[2] T1: normal taping

[3] T2: reverse taping

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11. Soldering



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12. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes			
PBSS302ND_2	20080218	Product data sheet	-	PBSS302ND_1			
Modifications:		of this data sheet has beer of NXP Semiconductors.	n redesigned to comply v	vith the new identity			
	 Legal texts 	 Legal texts have been adapted to the new company name where appropriate. 					
	 Section 1.1 "General description": amended 						
	 Section 1.4 "Quick reference data": I_{CM} conditions amended 						
	• Figure 2, 3, 4, and 6: amended						
	 Table 5: I_{CM} conditions amended 						
	Table 5: I _{BM} conditions amended						
	• Table 6: typing error for maximum value on 6 cm ² footprint amended						
	 Table 7: typical values for h_{FE} added 						
	Section 8 "Test information": added						
	Section 11 "Soldering": added						
	Section 13	"Legal information": update	d				
PBSS302ND 1	20050419	Product data sheet	-	-			

40 V, 4 A NPN low V_{CEsat} (BISS) transistor

13. Legal information

13.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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40 V, 4 A NPN low V_{CEsat} (BISS) transistor

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